

SUPPORTING INFORMATION

The Squeezing of Ion Populations and Peaks in Traveling Wave Ion Mobility Separations and Structures for Lossless Ion Manipulations using Compression Ratio Ion Mobility Programming (CRIMP)

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Figure S1



Figure S1. CRIMP timing diagram for the voltage potentials applied to the electrodes at the TT/ST interface. Yellow line shows the trigger to enable compression profiles. Potentials applied on the second electrodes (green line), third (blue line) and fifth (pink line) from the TT/ST interface are shown.